SEMICONDUCTOR®

ISL9R860P2, ISL9R860S3ST

8A, 600V Stealth™ Diode

General Description

The ISL9R860P2, ISL9R860S2 and ISL9R860S3S are Stealth $^{\rm M}$ diodes optimized for low loss performance in high frequency hard switched applications. The Stealth $^{\rm M}$ family exhibits low reverse recovery current (I_RRM) and exceptionally soft recovery under typical operating conditions.

This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low I_{RRM} and short t_a phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the StealthTM diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

October 2009

ISL9R860P2, ISL9R860S3ST

Features Soft Recoveryt_b / t_a > 2.5 • Fast Recovery t_{rr} < 25ns Operating Temperature 175°C Avalanche Energy Rated Applications · Switch Mode Power Supplies • Hard Switched PFC Boost Diode • UPS Free Wheeling Diode Motor Drive FWD SMPS FWD Snubber Diode Symbol JEDEC TO-263AB CATHODE (FLANGE)

Formerly developmental type TA49409.

JEDEC TO-220AC

ANODE

CATHODE

Package

CATHODE

(FLANGE)



Symbol	Parameter	Ratings	Units
V _{RRM}	Peak Repetitive Reverse Voltage	600	V
V _{RWM}	Working Peak Reverse Voltage	600	V
V _R	DC Blocking Voltage	600	V
I _{F(AV)}	Average Rectified Forward Current (T _C = 147°C)	8	Α
IFRM	Repetitive Peak Surge Current (20kHz Square Wave)	16	Α
I _{FSM}	Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	100	А
PD	Power Dissipation	85	W
E _{AVL}	Avalanche Energy (1A, 40mH)	20	mJ
Г _Ј , Т _{STG}	Operating and Storage Temperature Range	-55 to 175	°C
ΤL	Maximum Temperature for Soldering		
T _{PKG}	Leads at 0.063in (1.6mm) from Case for 10s	300	°C
	Package Body for 10s, See Techbrief TB334	260	°C

N/C

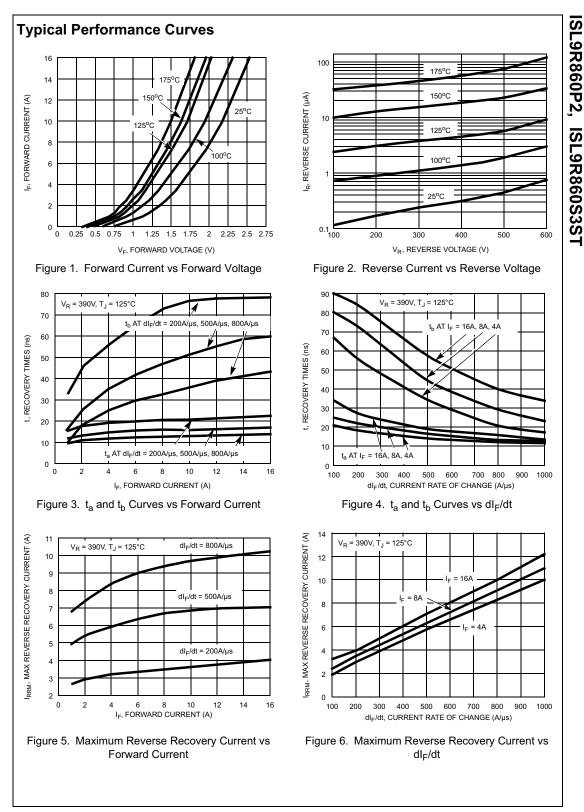
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ISL9R860P2, ISL9R860S3ST Rev. C2

NTTTT1.0mAOn State Characteristics V_F Instantaneous Forward Voltage $I_F = 8A$ $T_C = 25^\circ C$ -2.02.4VOptimize Characteristics C_J Junction Capacitance $V_R = 10V$, $I_F = 0A$ -30-pFSwitching Characteristics t_{rr} Reverse Recovery Time $I_F = 1A$, $dI_F/dt = 100A/\mu s$, $V_R = 30V$ -1825ns t_{rr} Reverse Recovery Time $I_F = 8A$, $dI_F/dt = 100A/\mu s$, $V_R = 30V$ -1825ns I_{RRM} Maximum Reverse Recovery Current $dI_F/dt = 200A/\mu s$,-28-ns I_{RRM} Reverse Recovery Current $dI_F/dt = 200A/\mu s$,-3.2-A Q_{RR} Reverse Recovery Charge $V_R = 390V$, $T_C = 25^\circ C$ -5.0-nc I_{rr} Reverse Recovery Charge $I_F = 8A$,- $I_F = 30A/\mu s$,- 3.4 -A Q_{RR} Reverse Recovery Charge $T_C = 125^\circ C$ - 3.4 -A Q_{RR} Reverse Recovery Charge $I_C = 125^\circ C$ - 5.3 -ns S Softness Factor (I_b/I_a) $dI_F/dt = 600A/\mu s$,- 2.5 I_{RRM} Maximum Reverse Recovery Current $V_R = 390V$,- 3.4 -A Q_{RR} Reverse Recovery Current $V_R = 390V$,- 5.3 -ns <t< th=""><th>R860S3SISL9R860S3STTO-263AB24mm800Electrical Characteristics $T_{C} = 25^{\circ}C$ unless otherwise notedSymbolParameterTest ConditionsMinTypMaxOff State CharacteristicsIral Instantaneous Reverse CurrentVR = 600VTC = 25^{\circ}C100IRInstantaneous Reverse CurrentVR = 600VTC = 25^{\circ}C100On State CharacteristicsVFInstantaneous Forward VoltageIF = 8ATC = 25^{\circ}C-2.02.4Opnamic CharacteristicsVRInstantaneous Forward VoltageIF = 8A, dIF/dt = 100A/µs, VR = 30V-1825C_JJunction CapacitanceVR = 10V, IF = 0A-30-Switching CharacteristicsIrReverse Recovery TimeIF = 8A, dIF/dt = 100A/µs, VR = 30V-2130IrReverse Recovery TimeIF = 8A, dIF/dt = 200A/µs,-28-IrReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.3JrReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,</th><th>Device</th><th>Marking</th><th>Device</th><th>Package</th><th>Tape Wid</th><th>th</th><th></th><th>Quar</th><th>ntity</th></t<>	R860S3SISL9R860S3STTO-263AB24mm800Electrical Characteristics $T_{C} = 25^{\circ}C$ unless otherwise notedSymbolParameterTest ConditionsMinTypMaxOff State CharacteristicsIral Instantaneous Reverse CurrentVR = 600VTC = 25^{\circ}C100IRInstantaneous Reverse CurrentVR = 600VTC = 25^{\circ}C100On State CharacteristicsVFInstantaneous Forward VoltageIF = 8ATC = 25^{\circ}C-2.02.4Opnamic CharacteristicsVRInstantaneous Forward VoltageIF = 8A, dIF/dt = 100A/µs, VR = 30V-1825C_JJunction CapacitanceVR = 10V, IF = 0A-30-Switching CharacteristicsIrReverse Recovery TimeIF = 8A, dIF/dt = 100A/µs, VR = 30V-2130IrReverse Recovery TimeIF = 8A, dIF/dt = 200A/µs,-28-IrReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,-3.3JrReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,3.7-QRRReverse Recovery CurrentIF = 8A, dIF/dt = 200A/µs,	Device	Marking	Device	Package	Tape Wid	th		Quar	ntity
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$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	n State	Charact	eristics	ł		4			
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$				I _F = 8A	T _C = 25°C	-	2.0	2.4	V
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$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $		-		I _F = 1A, dI _F /dt =	= 100A/µs, V _R = 30V	-	18	25	ns
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$				$I_F = 8A, dI_F/dt =$	= 100A/μs, V _R = 30V	-	21	30	ns
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	t _{rr}	Reverse R	ecovery Time			-	28	-	ns
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	I _{RRM}	Maximum	Reverse Recovery Current			-	3.2	-	Α
SSoftness Factor (t_b/t_a)dl _F /dt = 200A/µs, V _R = 390V, T _C = 125°C-3.7-I _{RRM} Maximum Reverse Recovery CurrentV _R = 390V, T _C = 125°C-3.4-AQ _{RR} Reverse Recovery ChargeI _F = 8A, 	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Q _{RR}	Reverse R	ecovery Charge	v _R = 390v, 1 _C =	= 25°C	-	50	-	nC
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	t _{rr}	Reverse R	ecovery Time			-	77	-	ns
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$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	I _{RRM}	Maximum	Reverse Recovery Current			-	3.4	-	А
SSoftness Factor (t_b/t_a)dl _F /dt = 600A/µs, V _R = 390V, T _C = 125°C-2.5-I _{RRM} Maximum Reverse Recovery CurrentV _R = 390V, T _C = 125°C-6.5-AQ _{RR} Reverse Recovery Charge195-nC-500-A/µsdl _M /dtMaximum di/dt during t_b -500-A/µshermal Characteristics R_{\thetaJC} Thermal Resistance Junction to Case1.75°C/V R_{\thetaJA} Thermal Resistance Junction to AmbientTO-22062°C/V	SSoftness Factor (t_b/t_a)dI_F/dt = 600A/µs, V_R = 390V, T_C = 125°C-2.5-I_RRMMaximum Reverse Recovery Current Um/dtV_R = 390V, T_C = 125°C-6.5-00195-195-dI_M/dtMaximum di/dt during t_b-500-hermal Characteristics $R_{\theta JC}$ Thermal Resistance Junction to Case1.75 $R_{\theta JA}$ Thermal Resistance Junction to AmbientTO-22062	Q _{RR}	Reverse R	ecovery Charge	1 _C = 123 C		-	150	-	nC
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	IRRMMaximum Reverse Recovery Current $V_R = 390V$, $T_C = 125°C$ -6.5- Q_{RR} Reverse Recovery Charge195-6.5- dI_M/dt Maximum di/dt during t_b -500-hermal Characteristics $R_{\theta JC}$ Thermal Resistance Junction to Case1.75 $R_{\theta JA}$ Thermal Resistance Junction to AmbientTO-22062	t _{rr}	Reverse R	ecovery Time			-	53	-	ns
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	IRRMMaximum reverse recovery current $T_{C} = 125^{\circ}C$ $I = 0.3$ $I = 0.3$ Q_{RR} Reverse Recovery Charge195- dI_M/dt Maximum di/dt during t_b -500-hermal Characteristics $R_{\theta JC}$ Thermal Resistance Junction to Case1.75 $R_{\theta JA}$ Thermal Resistance Junction to AmbientTO-22062	S	Softness F	actor (t _b /t _a)		s,	-	2.5	-	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	I _{RRM}	Maximum	Reverse Recovery Current			-	6.5	-	A
Contract eristics R _{θJC} Thermal Resistance Junction to Case - - 1.75 °C/V R _{θJA} Thermal Resistance Junction to Ambient TO-220 - 62 °C/V	Registre - - 1.75 Registre Thermal Resistance Junction to Case - - 1.75 Registre Thermal Resistance Junction to Ambient TO-220 - - 62	Q _{RR}			10 120 0			195	-	nC
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	dl _M /dt	Maximum	di/dt during t _b			-	500	-	A/µs
$R_{\theta JA}$ Thermal Resistance Junction to Ambient TO-220 62 °C/V	RθJA Thermal Resistance Junction to Ambient TO-220 - 62	hermal	Characte	eristics					-	
							-	-		°C/W
R _{0JA} Thermal Resistance Junction to Ambient TO-263 62 °C/V	R _{eta} Thermal Resistance Junction to Ambient TO-263 62						-	-		°C/W
		R_{\thetaJA}	Thermal R	esistance Junction to Ambient	TO-263				62	°C/W
			I		1		_1	<u> </u>	<u> </u>	<u>I</u>

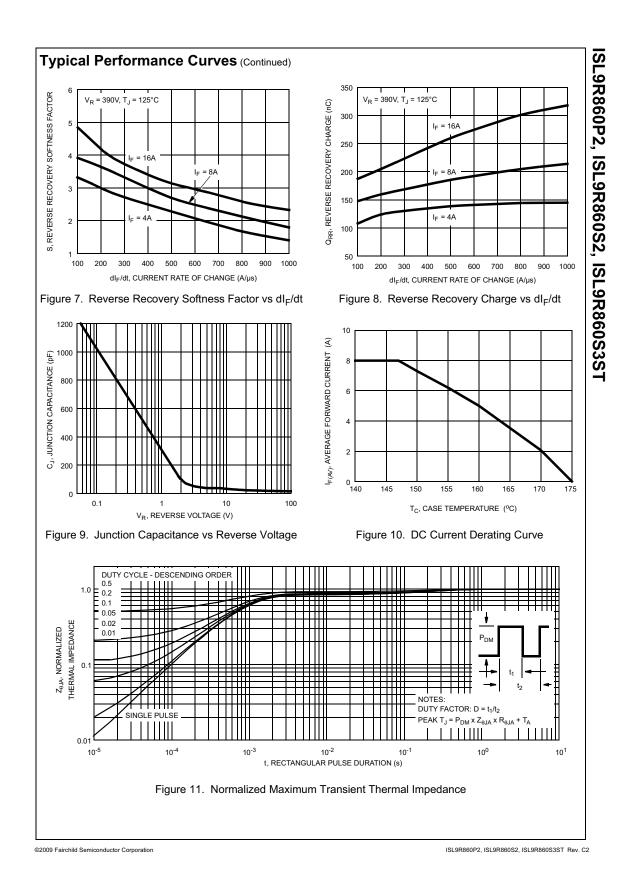
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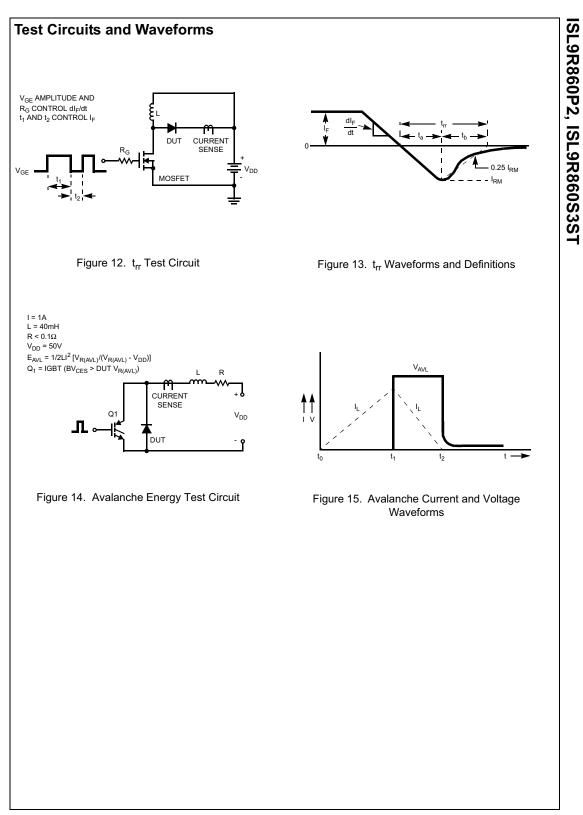
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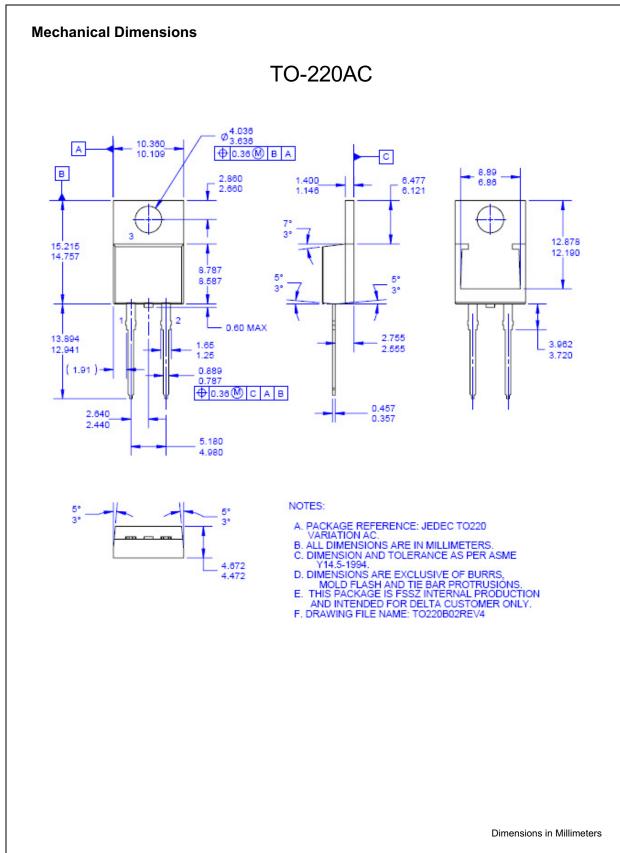
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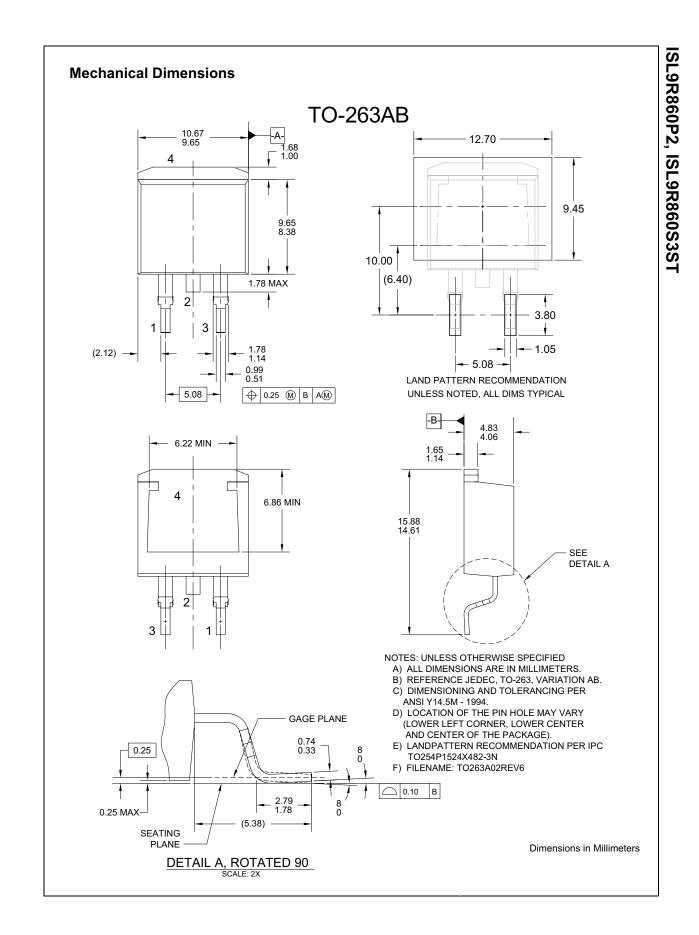


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